

Image Calibration and Instrument Signal Removal for the First Year of the LSST

ALEXANDER BROUGHTON ¹, AGNÈS FERTÉ ², AND CHRISTOPHER Z. WATERS ³

¹*Kavli Institute for Particle Astrophysics and Cosmology, SLAC National Accelerator Laboratory, 2575 Sand Hill Rd., Menlo Park, CA 94025, USA*

²*SLAC National Accelerator Laboratory, 2575 Sand Hill Rd., Menlo Park, CA 94025, USA*

³*Department of Astrophysical Sciences, Princeton University, Princeton, NJ 08544, USA*

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ABSTRACT

The Vera C. Rubin Observatory Legacy Survey of Space and Time (LSST) requires calibration products that provide uniform, stable, and accurate photometric and astrometric performance across the 3.2 gigapixel focal plane and throughout the 10-year survey. This paper details the algorithms and workflows used to produce instrument calibrations and remove instrumental artifacts for Data Preview 2 (DP2)—the first end-to-end processing demonstration using on-sky data with the LSST Camera (LSSTCam). We describe the verification, acceptance, and certification framework used to assess calibration quality and quantify residual systematics. We show baseline metrics on calibrated science images to evaluate the robustness of the calibration and instrument signature removal (ISR) data processing pipelines for DP2. Finally, we summarize the known limitations observed in DP2 production and outline expected algorithmic improvements for the first public LSST data release (Data Release 1, DR1).

1. INTRODUCTION

The Vera C. Rubin Observatory will conduct the 10-year Legacy Survey of Space and Time (LSST, [Ivezić et al. 2019](#)), imaging roughly 18,000 deg² of the southern sky in six broadband, optical–near-infrared (NIR) filters (*ugrizy*). Achieving the LSST science goals requires calibrating the instrument with high precision and uniformity so that raw detector readouts can be transformed into science-ready images and catalogs. Errors or non-uniformities in image calibration can introduce survey-scale photometric and astrometric systematics that propagate into downstream measurements and may be degenerate with astrophysical or cosmological signals ([J. H. Esteves et al. 2023](#)).

Key challenges to delivering this level of calibration include:

- 1. Instrument complexity:** The LSST Camera (LSSTCam) is the largest digital camera built for astronomy. Its 3.2-gigapixel focal plane consists of 205 fully depleted, backside-illuminated charge-coupled devices (CCDs) from two vendors (Teledyne e2v and Imaging Technology Laboratory, hereafter E2V and ITL). Detector-to-detector and amplifier-level variations require calibration and

processing algorithms robust to heterogeneous sensor behavior.

- 2. Data volume and cadence:** LSSTCam typically acquires 30 s exposures with ≤ 3 s read-out, yielding about 1000 exposures per night and nightly data rates of approximately 10 TB. The need for fast, efficient processing speed is driven by Prompt Processing for the alert database and the active optics system.
- 3. Calibration system and optics:** The calibration system (dome flats, LEDs, monochromator, and the Collimated Beam Projector or CBP) must provide uniform and repeatable illumination over a large focal plane through a fast converging ($f/1.2$) optical system.
- 4. Coupled instrumental effects:** Instrument signature removal (ISR) must correct artifacts in the reverse chronological order in which they imprint in the photon transfer chain. Calibration derivation follows the same ordering, since characterizing a given artifact requires that all effects imprinted before it have already been calibrated and removed. This is further complicated by partial degeneracies among instrument artifacts, which

necessitate iterative or “bootstrapped” approaches to converge on self-consistent calibration products.

5. **Evolving conditions and cadence:** Changing environmental conditions, multi-epoch calibration datasets, and evolving observing strategies require calibration production to be robust to non-uniform survey and telescope operations. The datasets discussed in this paper were collected before the dome was completed, before stabilization of thermal regulation systems, and before finalization of the precise detector operating mode.
6. **Verification, provenance, and operational reproducibility:** Calibration products must be accompanied by quantitative diagnostics for rapid data quality assessment, cross-time and cross-version comparisons, and clear acceptance and certification decisions for downstream processing. Products must be reproducible, versioned, and continuously validated as instruments and algorithms evolve.

The LSST Data Management Science Pipelines (NSF-DOE Vera C. Rubin Observatory 2025) implement this functionality using production pipelines and supporting tools to generate, verify, and publish calibration products for routine processing. The design benefits from lessons learned in LSST Data Preview 1 (DP1) (NSF-DOE Vera C. Rubin Observatory Team et al. 2025) and precursor surveys, including the Hyper Suprime-Cam Subaru Strategic Program (S. Miyazaki et al. 2012; H. Aihara et al. 2022; J. Bosch et al. 2017) and the Dark Energy Survey (T. D. E. S. Collaboration 2005; T. Diehl & F. T. D. E. S. Collaboration 2012; E. Morganson et al. 2018).

The first end-to-end demonstration of Rubin data processing on a substantial, internally consistent LSSTCam dataset is *Data Preview 2* (DP2). DP2 covers about 2,500 deg² in all six filters and includes commissioning and pre-survey operations data. This paper describes the calibration-production algorithms and the operational approach used to generate DP2 calibration products.

Our goals are to (1) make the DP2 calibration products interpretable to science users, (2) quantify our confidence in the quality of released data products, (3) provide a reference for future cross-survey synergies and science analyses, (4) make the processing reproducible for pipeline developers and operators, and (5) provide a reference point for expected improvements on the path to the first LSST public data release.

This paper is organized as follows. §2 introduces the LSST Camera and the CCD readout architecture rel-

evant to calibration. §3 describes the DP2 calibration datasets, the calibration system, and the criteria used to select input exposures. §?? presents the data processing overview and the physical detector model that organizes calibration production and ISR. §4 describes calibration product production and application, including algorithms and data products used in production. §5 integrates how those products compose during instrument signature removal for DP2 science data. §6 discusses calibration-epoch differences and residual systematics relevant to DP2. §7 describes how calibration products are verified, accepted, certified, and deployed, and §8 summarizes known limitations for DP2. §9 summarizes the DP2 calibration quality and outlines expected improvements toward Data Release 1 (DR1).

2. THE LSST CAMERA (LSSTCAM)

The Vera C. Rubin Observatory’s camera LSSTCam (<https://lsstcam.lsst.io/>) is the largest digital camera ever built to date. Its design and the technological progress it required, were developed in order to meet the requirements set by the ambitious goals of LSST, as described in [add citation to LSST Camera Verification Testing and Characterization and other SPIE papers](#). We have thus created an ISR approach specifically for the analysis of LSSTCam images. Figure 1 shows an example of the results from our ISR pipeline on an LSSTCam exposure, showing the corrections of large effects (such as the amplifier offset or crosstalk) as well as more subtle effects (such as the brighter fatter effect). We summarize here key points about LSSTCam and properties of its CCDs relevant for LSSTCam calibration in Rubin Data Management (DM).

2.1. LSSTCam CCDs

LSSTCam, is composed of 189 CCDs organized in rafts of 9 CCDs (3x3), in a focal plane mosaic presented in CTN-001 [add citation](#). In addition, 2 star guider CCDs and one split-wavefront CCD are at each four corners of the focal plane mosaic. We will focus only on the science CCDs in the following as no requirements are set on the calibration of the corner sensors within DM, although some calibrations are provided for the star guiders.

LSSTCam CCDs are made of 16 segments each, 8 at the top and 8 at the bottom of the CCD, read out through an amplifier. Segments are commonly referred to as amplifiers and will be in the rest of this paper. Each amplifier is 2048 pixels high and 512 pixels wide for e2v and [add ITL case](#). Figure 2 shows a diagram of the amplifier geometry and direction of electrons transportation in LSSTCam CCDs. The overscan regions

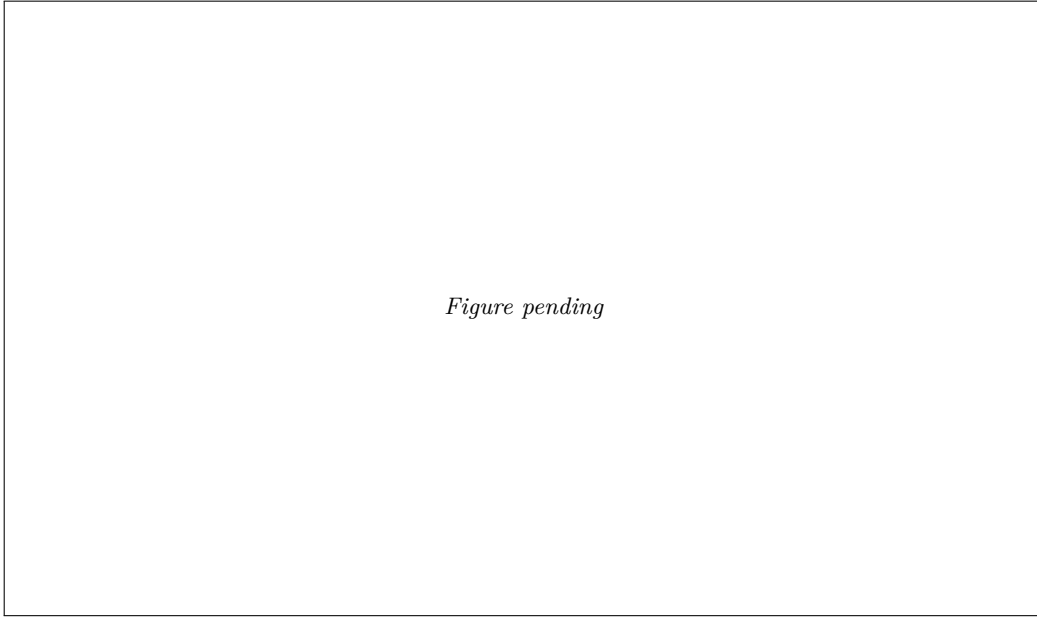


Figure 1. Here is an exposure before and after ISR.

are virtual pixels read to estimate charge transfer inefficiency (CTI), see 4.6 for my details. Figure 2 show an example of the signal read in the overscan region for ITL and e2v amplifiers.

2.2. Electronic Detector Model for LSSTCam

The calibration and instrument signature removal (ISR) pipeline removes instrumental effects from science data. For each effect observed in LSSTCam, the Rubin Science Pipelines define a calibration-generation task that produces the corresponding data product, and a correction task that applies that product during ISR.

Calibration and ISR tasks are organized as a pipeline based on our current model of the detector physics. The calibration production tasks are run in chronological order with respect to the photon transfer and data-acquisition chain, and ISR correction tasks are applied in the opposite order to the sequence in which effects accumulate along the signal path.

The algorithms and processing steps required for LSSTCam calibration and ISR were developed from measurements and analysis during electro-optical testing on the laboratory test stand at SLAC National Accelerator Laboratory, at the summit, and on the telescope in-dome during commissioning. [A. J. Roodman et al. \(2024\)](#) gives a detailed account of system characterization work and results from these campaigns. Figure 3 summarizes the instrumental effects identified in the photon transfer chain and their order.

We have built on the ISR approach of past optical surveys [here add citations for ISR procedures for other CCD optical experiments](#) to develop an ISR pipeline

specifically designed for LSSTCam. At Calibpalooza 2022 ([is their proceeding or document we can refer to?](#)) and during following years, we have indeed defined the electronic model of LSSTCam and associated effects in the photon to ADU signal chain. Figure 3 depicts the different steps in this chain and their physical ordering from the detector to the Readout Board (REB). [here add any citations that supports this description.](#)

The ISR pipeline implemented in the Rubin data processing aims at correcting each of these effects in the order opposite to which they happen.

3. DATA

Summarize the DP2 context relevant to calibrations: instrument, filters, observing period/epochs, detector layout, available exposure types (bias/dark/flat/science), and definitions of calibration epochs. Optionally add science context.

3.1. LSSTCam and CCD status for DP2

Analyzed with updated sequencer (s3v2).

to do: insert map as a percentage of used pixels: dead, bad and the dead ccd are in one color, color for CCDs worst than the median and green for best CCDs. Effective area: vignetted masked + defects.

3.2. Calibration System (CalSys)

Provide descriptions of auxiliary telescope/CBP/flat field illuminator/LEDs/monochromator and any instrumentation used for input datasets. Describe any system-level constraints that influenced calibration strategy.

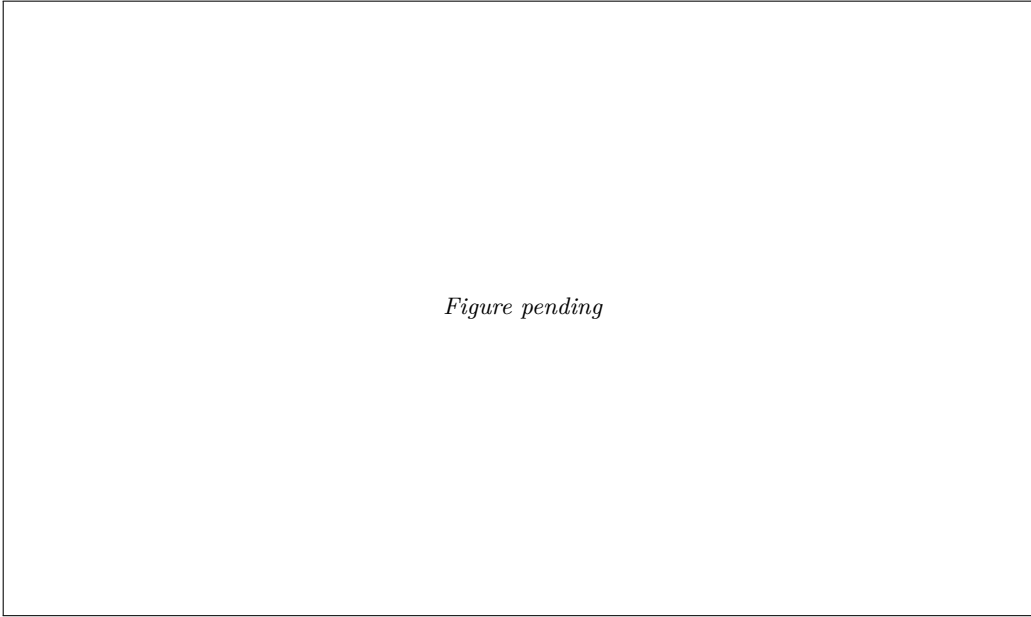


Figure 2. Here is an exposure in e2v amplifier and in ITL amplifier with rectangles around different regions (overscans, serial register) and graphs of the signal in their overscan regions.

Describe the LSST Camera and any technical limitations (bad detectors/amps). Introduce and define the sequencer.

3.3. *Data selection and corresponding calibration epoch*

Describe the data selection process for the DP2 dataset and calibration epoch. See 4.

4. CALIBRATION PRODUCTION AND APPLICATION

Each subsection will describe the calibration product, its construction algorithm, and the corresponding ISR correction task. We may also include a table of the data product and the name of the associated calibration task. Figure 5 summarizes calibration-product dependencies. The integrative ISR pipeline for DP2 science data, including the order in which corrections are applied (Figure 12), is described in §5.

4.1. *Curated Calibrations*

4.2. *Auxiliary Data Products*

4.3. *Crosstalk*

Describe how the crosstalk matrices are constructed.

4.4. *Defects*

We describe how defect masks are generated (bad pixels/columns, saturation trails, and other artifacts), the thresholds used, and how masks are combined across exposures.

4.5. *Non-Linearity*

Non-linearity (NL) describes a deviation from simple proportionality when mapping amplified voltage integrated during readout to the number of analog-to-digital units (ADU) or counts. Non-linearity is signal-dependent and is often not a simple function of signal level; it can change suddenly above a large signal level that is characteristic to each readout amplifier; and it can drift with sensor temperature and with time, as slow electronic shifts in the bias level accumulate over a long calibration campaign. In practice it introduces pixel-level measurement bias (up to x% from the true signal) and invalidates Poisson counting statistics and can interfere with measurement of gain (which shouldn't change or drift with signal level). Correcting NL to better than y% is therefore a prerequisite for reliable downstream calibration products and science analyses.

We can measure non-linearity by measuring the response of pixel values to a change in illumination level. The in-dome calibration illumination system can deliver an approximately uniform flux of light across the LSST-Cam focal plane. Given a known change in some input illumination level, we should be able predict a change in the number of counts in an image, which we can then compare to the measured change counts.

We do not have independent measurements of the photodiode current produced by our calibration illumination system that we can integrate of the exposure time and use as a baseline truth of the amount of incident light while taking an exposure. The exposure time, which is precisely measured, makes a natural proxy for miss-

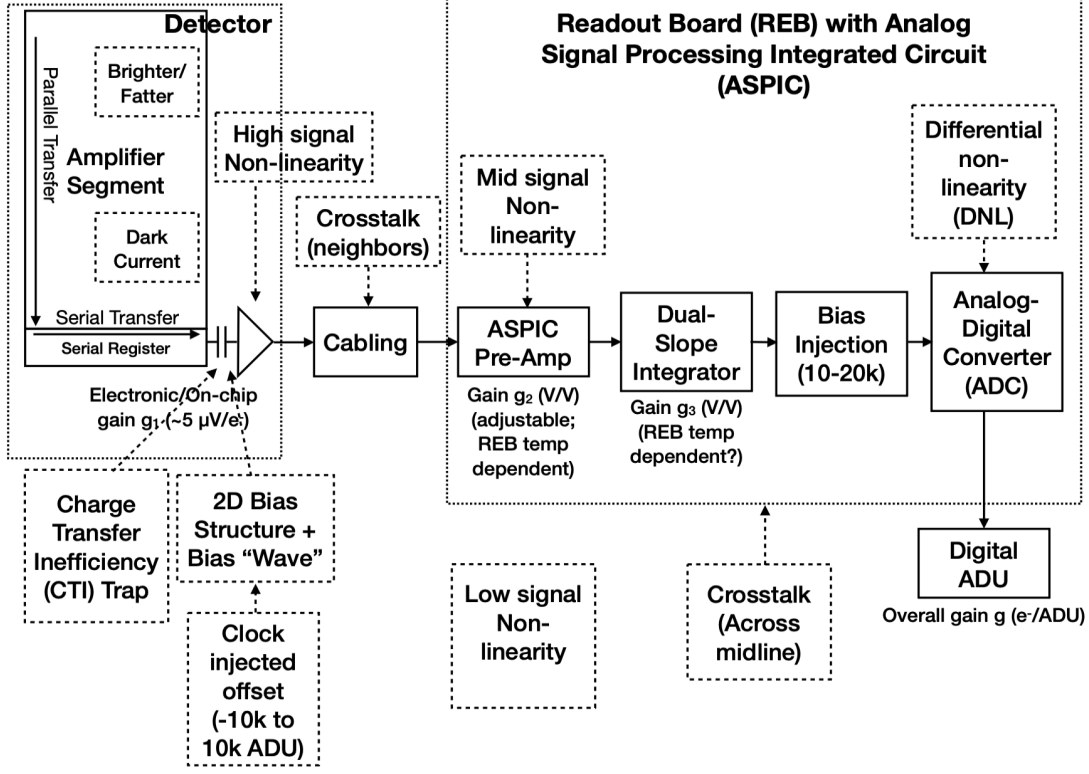


Figure 3. Photon transfer and data-acquisition model for the LSSTCam detectors and electronic readout board (REB). Instrumental effects seen in images are shown as dashed boxes; arrows indicate where each effect enters the chain. Low-signal nonlinearities in LSSTCam’s detector response have been observed, but their origin is not yet established; that contribution appears as a disconnected box.

ing photodiode measurements. We therefore calibrate NL by fitting a relation between exposure time (Δt , abscissa) and the mean measured flat-field signal (μ , ordinate).

We measured 543×2 flat field exposures at evenly spaced illumination levels. We went as low as 100 analog-to-digital units (ADU) and continued beyond pixel saturation. At each illumination level, a pair of flats was acquired by varying both photodiode current and exposure time to achieve the targeted levels, measuring the mean signal level as $\mu_i = \text{avg}(F_i^{(1)}, F_i^{(2)})$ (in ADU). These data were acquired with illumination levels decided in random order to decouple signal-dependent non-linearity and time-dependent drifts in non-linearity.

Figure 6 shows the resulting relation for a representative amplifier. Discontinuities appear at the boundaries between LED current settings, producing different signal levels for the same exposure time. These data are partitioned into groups associated with distinct LED illumination settings. Grouping is determined by computationally searching for jumps in the ratio of mean detector signal to exposure time or via exposure meta-

data. Within each group we allow a distinct proportionality constant k_j to capture the size of the jumps.

To first order, the trend between exposure time and the mean measured flat-field signal over properly scaled groups is linear and related to the intrinsic gain in each readout channel. We can fit a simple slope and intercept to this trend to the low signal points; the highest signal level in each channel above which this approximation break is the “linearity turnoff” (as indicated in Figure 7). Points above the turnoff are excluded from the NL fit because there is a maximum signal above which the measured counts can no longer be trusted due to hardware limitations at the output of the detector (Figure 3).

The NL model we fit to this relation is an extension of the formalism developed by P. Astier et al. (2019). We represent the deviation from linearity by an Akima spline $S(\mu)$ of the measured mean signal μ .

For each exposure i in group j we define the residual ratio

$$r_i = \frac{\mu_i - S(\mu_i) - O}{k_j D_i} \quad (1)$$

where D_i is the data used for the abscissa (exposure time), O is an optional constant offset that absorbs scat-

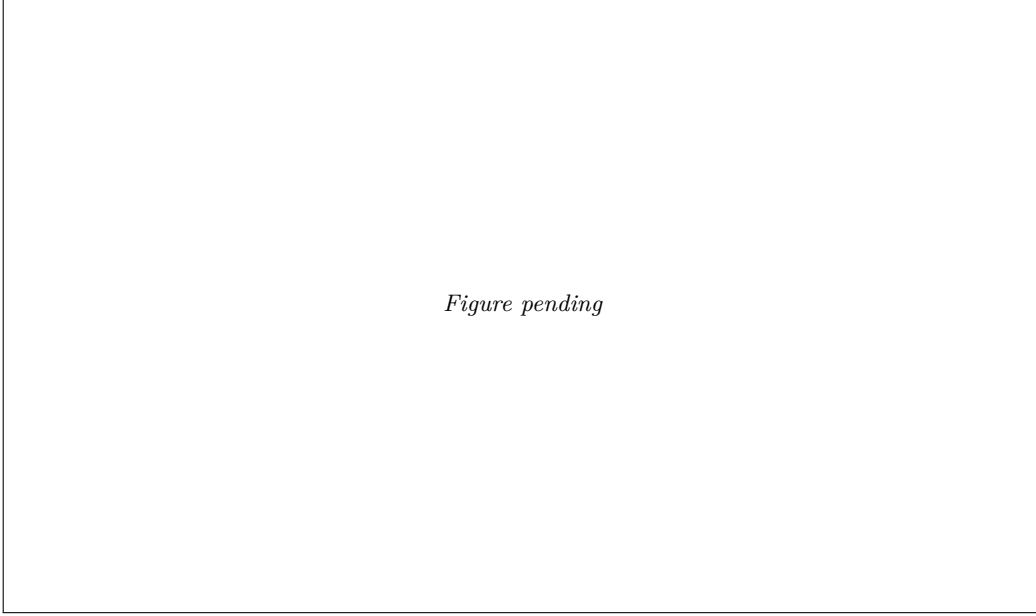


Figure 4.

tered light or other signal not proportional to D_i , and w_i are weights.

The fit minimizes a uniformly weighted ($w_i = 1$) least-squares objective over all accepted points:

$$\chi^2 = \sum_i w_i (r_i - 1)^2. \quad (2)$$

The fit is subject to the boundary conditions $S(0) = 0$ and $\langle S(\mu) \rangle = 0$ over the fit range. The first constraint fixes the origin such that zero illumination is always measured zero measured signal; the second ensures that the spline captures deviations from linearity independently from knowing the true amplifier gain.

In addition, any hardware sensitivities are absorbed by nuisance parameters that we parameterize as 1st order linear corrections to μ before the spline is evaluated:

$$\mu \rightarrow \mu (1 + \alpha T_i), \quad (3)$$

$$\mu \rightarrow \mu (1 + \beta t_i), \quad (4)$$

where T_i is a readout temperature (referenced to the median over the campaign), t_i is the Modified Julian Date (MJD) of the midpoint of the shutter open time, and α and β are fitted coefficients that describe each sensitivity. For LSSTCam DP2 calibration production we fit both the temperature and temporal coefficients as well as the scattered-light offset O on the spline.

We could perform this fit independently for every amplifier on every detector. However, most of the non-linearity is common to all amplifiers due to similar readout architectures, with only small amplifier-to-amplifier variations on top that. In addition, each independent

fit to every amplifier would pick up not just the intrinsic non-linearity in amplifiers, but also exposure-to-exposure spatial illumination variation that occurs during the calibration campaign. To better characterize this, it makes sense to perform a spline fit on each amplifier relative to both a single reference exposure and a reference amplifier on the same detector.

We can distinguish an *absolute* non-linearity in a single reference amplifier on a detector and the *relative* non-linearity of other amplifiers to that reference amplifier, the process for which is summarized in Algorithm 1. After choosing a reference amplifier and a reference exposure, we do (1) a relative spline fit on every other amplifier using the variation of its mean flat-field signal μ relative to the reference amplifier and to the μ in a single reference exposure, and then (2) an absolute spline fit on the reference amplifier using the usual form μ versus Δt . Every amplifier on a detector has a shared absolute spline fit based on the reference amplifier for that detector and a relative spline fit computed relative to a reference amplifier and a reference exposure ($S_{\text{rel}}(\mu) = 0$ for the reference amplifier).

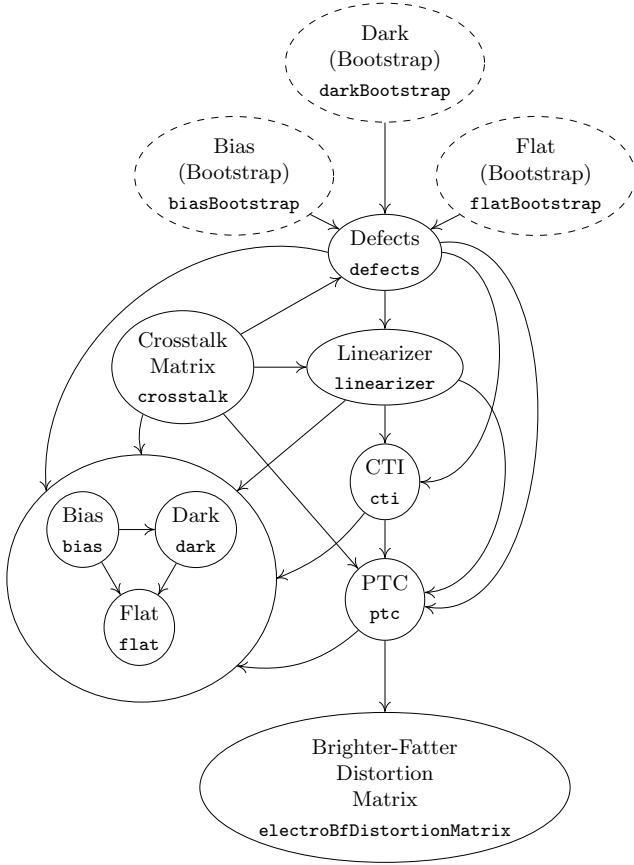


Figure 5. Calibration production dependency graph. Arrows indicate data or dependency flow (“x → y” means “y depends on x”). Solid outlined boxes represent datasets that are deployed/released with data products while dashed boxes represent internal or intermediate datasets that are not formally released to users.

Algorithm1 Double-spline linearity fit (single detector)

```

1: for each amplifier  $a$  do
2:    $k_j \leftarrow \text{FIND\_GROUPS}(\mu_a, \Delta t)$ 
3:    $\text{COMPUTE\_LINEARITY\_TURNOFF}(\mu_a, \Delta t)$ 
4: end for
5: choose reference amplifier  $\text{ref}$  with the highest linearity
  turnoff
6: choose reference exposure  $i_0$ , the flat whose mean signal
   $\mu_{\text{ref}} = 10^4$  on amplifier  $\text{ref}$  is nearest the target signal
  level
7: for each exposure  $i$  do
8:   for each amplifier  $a \neq \text{ref}$  do
9:      $D_i^{\text{rel}} \leftarrow \mu_{\text{ref},i} \times (\mu_{a,i_0} / \mu_{\text{ref},i_0})$  (Relative Abscissa)
10:     $\mu_i^{\text{rel}} \leftarrow \mu_{a,i}$  (Relative Ordinate)
11:   end for
12:    $D_i^{\text{abs}} \leftarrow \Delta t_i$  (exposure time)
13:    $\mu_i^{\text{abs}} \leftarrow \mu_{\text{ref},i}$  (measured counts)
14: end for
15:  $S_{\text{abs}}(\mu), O, \alpha, \beta \leftarrow \text{MINIMIZE}(\text{Equation 2}, D_i^{\text{abs}}, \mu_i^{\text{abs}}, k_j)$  ▷ Spline fit
16:  $S_{\text{rel}}(\mu) \leftarrow \text{MINIMIZE}(\text{Equation 2}, D_i^{\text{rel}}, \mu_i^{\text{rel}}, k_j)$ 

```

Figure pending

Figure 6. Mean flat-field signal as a function of exposure time for a representative amplifier. Discontinuities at LED current-setting boundaries partition the data into distinct illumination groups.

Figure pending

Figure 7. Linearity turnoff for a representative amplifier. The turnoff marks the highest signal level below which the exposure-time-to-signal relation remains approximately linear.

To determine the corrected mean signal level, we can interpolate the Akima splines to compute a correction: $\mu' = \mu - S_{\text{rel}}(\mu) - S_{\text{abs}}(\mu)$.

If each amplifier is properly linearized around its true gain, we should observe in every exposure that the illu-

mination level is coherent between amplifiers and detectors. If the linearization is miscalibrated or biased (either because exposure time is not a good proxy for the true integrated photodiode or if constraining $\langle S(\mu) \rangle = 0$ is biased), the amplifiers and detectors will show signal-dependent fractional offsets in mean signal levels in each flat similar to a mis-estimation of gain.

We can check this how the linearized mean signal levels deviate from an overall linear relation over some set of detectors in a given exposure: For each exposure i , we form the linearized signal, μ'_i , on the reference amplifier on every detector and compute the fractional residual:

$$r_i = \frac{\mu'_i - m_i D_i}{y_i}, \quad (5)$$

where m_i is the slope of a linear fit to μ'_i versus D_i . We take the median $\langle r \rangle_i$ over a subset of focal-plane detectors (in the center of the focal plane) in that exposure and derive a multiplicative correction

$$N_i = \frac{1}{1 - \langle r \rangle_i}, \quad (6)$$

that we use to rescale the abscissa ($D_i \rightarrow N_i D_i$) and enforce that the linearization produces a coherent illumination across all detectors.

We can then re-compute the double-spline fit with the normalized abscissa on the reference amplifier. We can repeat the cycle (normalize, spline, normalize, etc.) recursively several times, each time computing the normalization as

$$N_i = \frac{N_i^{\text{prev}}}{1 - \langle r \rangle_i}. \quad (7)$$

By including constraints from the whole focal plane, we get to take advantage of the added statistical information. After one iteration, this gives us a factor of N_x improvement in precision, with added value dropping rapidly after two iterations.

In ISR, given an image with pixel values measured in counts (F_{ij}), the final spline model can be interpolated, providing a continuous map from measured counts to the corrected counts for any pixel value within the range of 0 signal to the linearity turnoff, computed as: $F'_{ij} = F_{ij} - S_{\text{rel}}(F_{ij}) - S_{\text{abs}}(F_{ij})$.

4.6. Deferred Charge

Several distinct effects in the readout chain displace charge from its pixel of origin and leave correlated structure in the serial overscan: (1) a pixel-to-pixel fractional loss during charge transfer referred to as “global CTI”, (2) a local electronic-offset hysteresis in the output amplifier that mimics deferred charge in the first few overscan columns, and (3) localized capture and delayed release of charge by isolated trap sites in the serial register.

Strictly, only global CTI is “charge transfer inefficiency” in the textbook sense, but because all three enter at the same point in the photon transfer chain (Figure 3) and produce overlapping signatures in the serial overscan, we model them together and produce a single calibration data product that we loosely refer to as “CTI” in Figure 5. These effects are measured, modeled, and corrected together using the extended pixel edge response (EPER) estimator developed for LSSTCam by A. Snyder et al. (2021).

Calibrating deferred charge uses the same input data as the linearity dataset (§4.5), estimating the residual charge in electrons left in the overscan region after integrating and reading out flat field images over a wide range of signal levels. The global CTI is quantified by a unitless fraction, but the trap size and the electronic drift-scale all carry signal-dependent physical units, so an imperfect conversion from counts back to physical electrons biases the eventual correction. This calculation therefore needs to happen in native electron units, so we need to remove signal-dependent non-linearities that occur when the signal is measured as counts and estimate a gain conversion from counts to electrons. For each input exposure, we apply an intermediate pass of instrument signature removal that applies defect masking and non-linearity correction, and converts pixel values to electrons, and also measures the overscan EPER statistics for each readout channel.

The natural way to convert from counts to electrons is to use the gain inferred from the PTC (§4.7), but the PTC needs to be CTI-corrected to get the most accurate inferred gains, creating what seems like a circular dependency between CTI and PTC calibration production. We break the cycle by bootstrapping. We create a temporary (intermediate) PTC that is not CTI-corrected, which we fit (see §4.7) to derive an initial rough estimate of the per-amplifier gain. That estimate is stored and applied during the ISR of the flat field images before calculating the EPER statistics. We find that the gains from a PTC without CTI correction are close enough to the final gains measured from a fully calibrated PTC (typically within 1% of the true gains). At this level, the rough gains are accurate enough for CTI calibration. The global-CTI fit is unit-free and so insensitive to any gain error, and the trap and local-offset amplitudes have only weak sensitivity to the few-percent gain bias that remains in the bootstrap estimate.

An example of the measured serial EPER statistics as a function of signal level for a single channel readout is shown in Figure 8. The global CTI produces an overall offset of this curve at all signal levels, the electronic offset produces a linear slope in the curve as a function

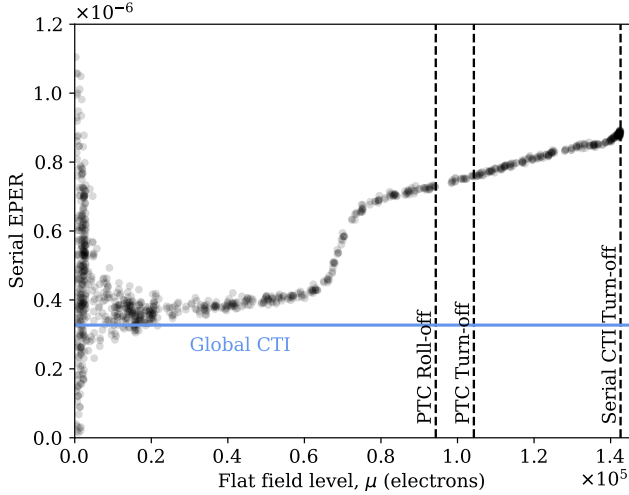


Figure 8. Serial EPER statistics as a function of flat-field signal level for detector/amplifier R22-S10/C04. Vertical markers indicate the PTC rolloff and turnoff thresholds (described in §4.7) and the serial CTI turnoff derived from the low-signal trend. The global CTI fit produces the overall offset of the measured curve at all signal levels.

of signal level, and the serial traps produce non-linear jumps that “turn on” above some signal level after a trap fills up and begins releasing charge with a characteristic timescale. There is a point at high signal levels at which we can no longer effectively transfer charge pixel to pixel, which we define as the “serial CTI turnoff” as indicated in the figure. We calculate this point as the highest mean signal for which the serial EPER remains consistent with a sigma-clipped linear fit to the low-signal points. For the majority of readout channels, the image region flat field level was not high enough to observe a serial CTI turnoff, which we then set as the maximum observed signal level.

The CTI solver simulates charge readout and each of the three effects at the amplifier image level for a given set of parameters. The model in the simulation is parameterized by a global serial CTI parameter b that is a fractional charge loss per pixel transfer, a local electronic offset described by drift scale A_L and decay time τ_L , and a spline-based serial charge-trap decay model whose size is allowed to depend on the signal in the last imaging column. We perform a least squares fit that finds the optimal set of parameters that can reproduce the measured overscan statistics trend as a function of signal level. Then the solver fits these parameters to the overscan image in stages. First, it varies only the local offset parameters, then the global CTI parameter, and then the trap capture curve from residuals between model and data. Exposures above configured flux limits are excluded from each stage (typically 10^4 electrons

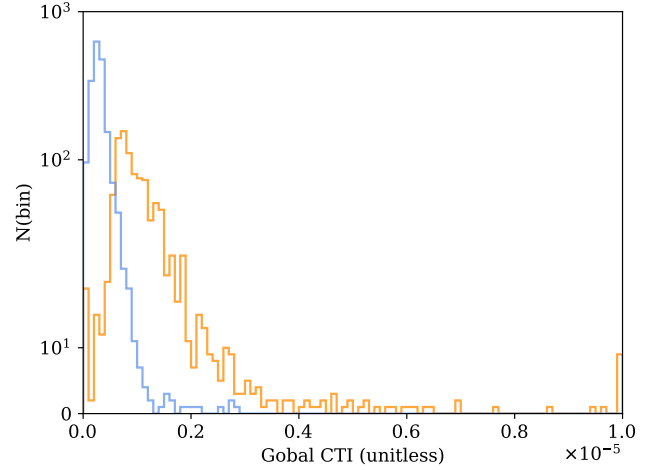


Figure 9. Distribution of inferred global serial CTI across all science sensor amplifiers on the LSSTCam focal plane. *Blue*—Teledyne e2v (E2V) detectors; *Orange*—Imaging Technology Laboratory (ITL) detectors. The fit to the deferred charge model allows global CTI to vary up to 1.0×10^{-5} .

for the global CTI fit and 1.5×10^5 electrons for trap fitting).

The LSST Science Requirements Document requires that total deferred charge measured by EPER be kept under a total of 5×10^{-6} for signal levels below saturation level on each amplifier (citation needed). Within the population of amplifiers in active science detectors, only 95 amplifiers do not meet this requirement without ISR correction. Figure 9 shows the distribution of inferred global CTI across all amplifiers on the LSSTCam focal plane, and we show that 26 have a global CTI offset that is already above the maximum allowed threshold. The majority of these (19) are bad amplifiers that are in the detector corners (C00, C07, C10, C17) positioned near the serial register, and it is possible that what is inferred as global CTI could be a serial trap that turns on at very low signal levels (below the 10^4 electron level) and appears as an overall offset that is mistaken for global CTI.

When correcting deferred charge from an image during ISR, the deferred-charge correction takes in these fit parameters and applies the inverse operators from the model. The global CTI and local-offset fits, and the inverse correction operators applied during ISR, are the same for both ITL and E2V sensors, but serial traps are fitted only on ITL since it was observed that E2V sensors had small trap size that was difficult to measure beyond noise fluctuations and already negligible enough not to require correction. After applying a deferred charge correction, we can re-compute the EPER statistics on the

corrected dataset and find that all amplifiers meet the science requirements.

While there can be deferred charge from a charge transfer in the parallel direction (shift row-to-row), in principle this is a difficult quantity to estimate accurately from parallel overscan statistics. EPER statistics computed in the parallel overscan region are noisy and reveal no statistically significant charge residuals, so we do not apply any parallel deferred charge correction to science images.

4.7. Photon Transfer Curve (PTC)

The photon transfer curve (PTC) characterizes how pixels respond to varying signal levels in a given wavelength band by measuring covariances between pixels in flat field exposures across a range of illumination levels. This dataset provides critical calibration information including amplifier-level read noise and gain for variance plane estimation, saturation thresholds for masking, and parameters needed to correct for non-linearity, charge transfer inefficiency (CTI), and the brighter-fatter effect. All of these parameters can differ at the amplifier level.

Let F_1 and F_2 denote the two flats at a given illumination level, and let $\mu = \text{avg}(F_1, F_2)$ denote the mean signal level (in ADU) over the image and away from the detector edges. The covariance between a pixel $\mathbf{x} = (0, 0)$ and a neighbor at pixel $\mathbf{x}' = (i, j)$ is:

$$C_{ij} = \frac{1}{2} \text{Cov}(F_1(\mathbf{x}) - F_2(\mathbf{x}), F_1(\mathbf{x}') - F_2(\mathbf{x}')). \quad (8)$$

Pre-model fit—Preliminarily, we fit only the variance to an approximate exponential relation derived in [P. Astier et al. \(2019\)](#) (their Eq. 16).

$$C_{00}^{\text{exp. approx}}(\mu) = \frac{1}{2g^2 a_{00}} [\exp(2a_{00}\mu g) - 1] + \frac{n_{00}}{g^2}. \quad (9)$$

In this expression, covariances are contributed by a gain g (electrons/ADU), noise pedestal n_{00} (electrons²), and a single brighter-fatter coefficient a_{00} (1/electrons) which has the effect of decreasing the image variance.

Near saturation, the variance deviates from this functional form, exhibiting a gradual rollover rather than a sharp cutoff due to electrostatic effects that are difficult to model analytically. On top of the exponential approximation, we introduce an empirical saturation term:

$$C_{00}^{\text{sat}}(\mu) = \begin{cases} -e^{-(\mu-\mu_0)/\tau} & \mu \geq \mu_0 \\ 0 & \mu < \mu_0 \end{cases}, \quad (10)$$

where μ_0 marks the onset of the PTC “rolloff” effects and τ controls the shape of the rollover. The total preliminary fit model is $C_{00}^{\text{prelim.}}(\mu) = C_{00}^{\text{exp. approx}}(\mu) +$

$C_{00}^{\text{sat}}(\mu)$ to the unweighted points. This fit is performed iteratively with additional 3 sigma clipping until convergence. The “PTC turnoff” is defined as the signal level of the last unmasked point following the fit to only the exponential approximation, typically corresponding to the maximum of the variance curve and generally higher than the rolloff threshold. The “PTC rolloff” is the signal level where $C_{00}^{\text{prelim.}}(\mu)$ and $C_{00}^{\text{exp. approx}}$ deviate by more than 1%.

Final model fit—With the remaining points below the PTC rolloff, we fit the complete covariance expansion from [P. Astier et al. \(2019\)](#) (their Eq. 20):

$$C_{ij}^{\text{model}}(\mu) = \frac{\mu}{g} [\delta_{i0}\delta_{j0} + a_{ij}\mu g + \frac{2}{3} ([\mathbf{a} \otimes \mathbf{a} + \mathbf{ab}]_{ij}) (\mu g)^2 + \frac{1}{6} (2\mathbf{a} \otimes \mathbf{a} \otimes \mathbf{a} + 5\mathbf{a} \otimes \mathbf{ab})_{ij} (\mu g)^3 + \mathcal{O}[(\mu g)^4]] + \frac{n_{ij}}{g^2}, \quad (11)$$

where a_{ij} (electrons)^{−1} represents the fractional change in pixel area per stored charge due to boundary motion from the brighter-fatter effect, b_{ij} (electrons)^{−1} captures weaker time-dependent corrections, g is the gain (electrons/ADU), and n_{ij} is the constant noise contribution (electrons)² (e.g., $n_{00} \sim (5.7 \text{ electrons})^2$ on the diagonal, with off-diagonal terms determined by read electronics and overscan). The symbol $\mathbf{ab}$ denotes element-wise matrix multiplication, and $\otimes$ represents discrete convolution. In practice, the b_{ij} parameter is inferred to be just noise around a value of zero. The size of the covariance matrix ($n \times n$) is determined by the range of the brighter-fatter effect (see §4.8). Figure 10 shows an example fit for amplifier C03 on detector 94, illustrating the measured C_{00} points, the preliminary exponential approximation with saturation roll-off, and the final variance from Eq. 11.

Because the gains are fit independently per amplifier, small fitting residuals can leave flux discontinuities at amplifier boundaries within a detector. We add a subsequent step that measures the relative offsets between amplifiers in flat fields after gain correction and computes small adjustments to the gain to make the detector image continuous while preserving the average gain across the detector. We compute the average gain adjustment in flat fields across a range of signal levels, and use these to produce overall “adjusted gains”. The adjustments to the gain are always small (less than 0.03), and uncorrelated between detectors. These final gains are used for conversion of science images to elec-

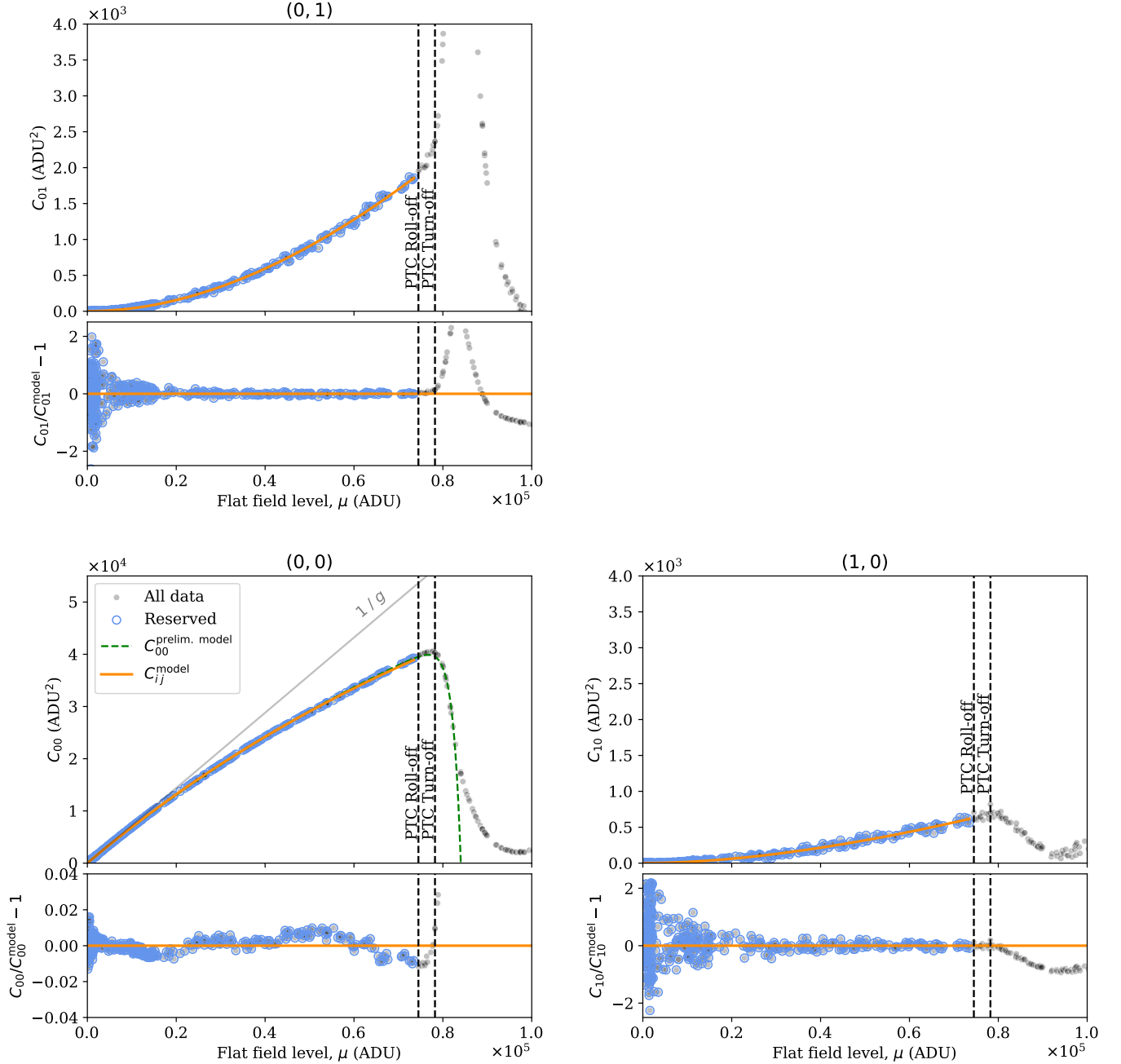


Figure 10. Example PTC fit for amplifier C03 on LSSTCam detector 94. Measured C_{00} covariance points are compared to the preliminary fit (exponential approximation plus saturation roll-off) and the final full-covariance model variance. Vertical markers indicate the PTC rolloff and turnoff thresholds.

tron units and construction of the variance plane for source detection.

The PTC calibration products are applied during instrument signature removal of science images in three ways. First, the gain converts pixel values from ADU to electrons. Second, the gain and read noise inform variance plane estimation. Third, the saturated pixel mask flag (denoted “SAT”) is set for all pixels with values greater than or equal to the PTC turnoff threshold.

4.8. Brighter-Fatter Effect

The brighter-fatter (BF) effect is the first influence the detector has on an incident signal (Figure 3). Accumulated electrons in a pixel repel incoming charges into neighboring pixels. Brighter point sources therefore appear wider in the recorded images. This electrostatic effect reduces to an effective change in pixel area and introduces correlations between nearby pixel values. The effect is intrinsic to thick CCDs and can significantly

bias point-spread-function (PSF) photometry and shape measurement.

The BF effect has been extensively characterized for LSSTCam by laboratory and in-dome commissioning measurements (A. Broughton et al. 2024). The strength of the effect is anisotropic ($a_{01}/a_{10} \sim 3$), long-ranged (~ 10 px), and wavelength dependent. It is also about twice as strong in the E2V-family detectors as in ITL-family detectors.

Several BF correction methods have been proposed and implemented in the LSST Science Pipelines (D. Gruen et al. 2015; W. R. Coulton et al. 2018; P. Astier & N. Regnault 2023; A. Broughton et al. 2024), and they differ widely in their underlying assumptions. A. Broughton et al. (2024) found that modeling individual boundary shifts for every pixel (N, S, E, W) is required for adequate correction at the level needed for LSST Y10 science requirements. Flat-field pixel correlations can measure only the net per-pixel area change, so determining these boundary shifts requires additional electrostatic modeling. For processing raw images from DP2, we use the P. Astier & N. Regnault (2023) algorithm developed for Hyper Suprime-Cam, which derives from electrostatic physics and treats each pixel boundary individually.

Calibration of the BFE using this algorithm takes the form of modeling a charge cloud at the bottom of a pixel, computing how the effective areas of nearby pixels would be expected to change electrostatically in response. It adjusts some geometric parameters (summarized in Table 1), and solves Gauss’s law to compute the shift of pixel boundaries and the relative change in pixel area from each shift ($\mathbf{a}^N, \mathbf{a}^S, \mathbf{a}^E, \mathbf{a}^W$). We optimize these parameters to best fit the measured net pixel area changes ($\mathbf{a}$ from Eq. 11):

$$\mathbf{a} = \mathbf{a}^N + \mathbf{a}^S + \mathbf{a}^E + \mathbf{a}^W. \quad (12)$$

In principle, the BFE can vary amplifier-to-amplifier, but we have observed only noise-level variations in the pixel distortion matrices across amplifiers and even detector families. For this reason, and to avoid discontinuous amplifier boundaries, the fit is performed at the detector level. All a_{ij} matrices from well-behaved amplifiers are 3σ -clipped elementwise and averaged into a detector-mean a_{ij} ; the scatter becomes the per-element uncertainty, and a single fit is run against this average pixel distortion matrix. The output calibration data product is the set of model parameters and a model that can be evaluated per-detector.

Applying this calibration to remove the effect during ISR uses the boundary-shift matrices $\mathbf{a}^N, \mathbf{a}^S, \mathbf{a}^E$, and $\mathbf{a}^W$ to redistribute flux accordingly. We tile these into

Table 1. Parameter Priors for the Electrostatic Brighter-Fatter Effect (BFE) Model Fit

Parameter	Prior
Si thickness, t (μm)	100 (fixed)
Pixel size, p (μm)	10 (fixed)
Charge cloud height, z_q (μm)	$0 \leq z_q \leq t/2$
Charge cloud length, a (μm)	$10^{-5} \leq a \leq 0.35p$
Charge cloud width, b (μm)	$10^{-5} \leq b \leq 0.35p$
Potential well vertex height, horizontal z_{sh} (μm)	$0 \leq z_{sh} \leq t/2$
Potential well vertex height, vertical z_{sv} (μm)	$0 \leq z_{sv} \leq t/2$

NOTE—Priors on the fit parameters are informed by pixel-level simulations of the electric fields in these pixels (C. Lage et al. 2017). The potential well vertices refer to the heights above the front-side of the CCD to the saddlepoints in the electric field that defines the pixel boundaries in the vertical (0, 1) and horizontal (1, 0) directions. The electrostatic model assumes that the stored charge cloud in the sensor takes the form of a flat, rectangular sheet of charge with length (a) and width (b). The inequality constraints $z_{sh} > z_q, z_{sv} > z_q$ are enforced during optimization, which is true in the unsaturated signal level regime.

two, $(2n + 1) \times (2n + 1)$, convolution kernels K^H and K^V for the horizontal and vertical shifts, respectively; we apply sign flips and edge adjustments so each matrix sums to zero. These matrices need not be symmetric, which is more realistic per A. Broughton et al. (2024). Figure 11 shows an example pair of these kernels for amplifier C03 on detector 94, illustrating the dipole-like, charge-conserving structure that redistributes flux across the vertical and horizontal pixel boundaries.

For an image Q_{ij} in natural gain-corrected units of electrons, the amount of charge lost over the vertical and horizontal boundaries is:

$$\begin{aligned} \delta_{ij}^H &= \frac{1}{2} \sum_{kl} K_{kl}^H Q_{i-k, j-l}, \\ \delta_{ij}^V &= \frac{1}{2} \sum_{kl} K_{kl}^V Q_{i-k, j-l}, \end{aligned} \quad (13)$$

The $1/2$ prefactor accounts for the average BFE assuming a constant rate of charge accumulation during an exposure. The corrected image is assembled by removing the charge each pixel lost across its N/E boundaries and adding what it gained from S/W neighbors, guaranteeing charge conservation by construction, $\sum_{ij} Q_{ij}^{\text{corr}} = \sum_{ij} Q_{ij}$. This correction does not require

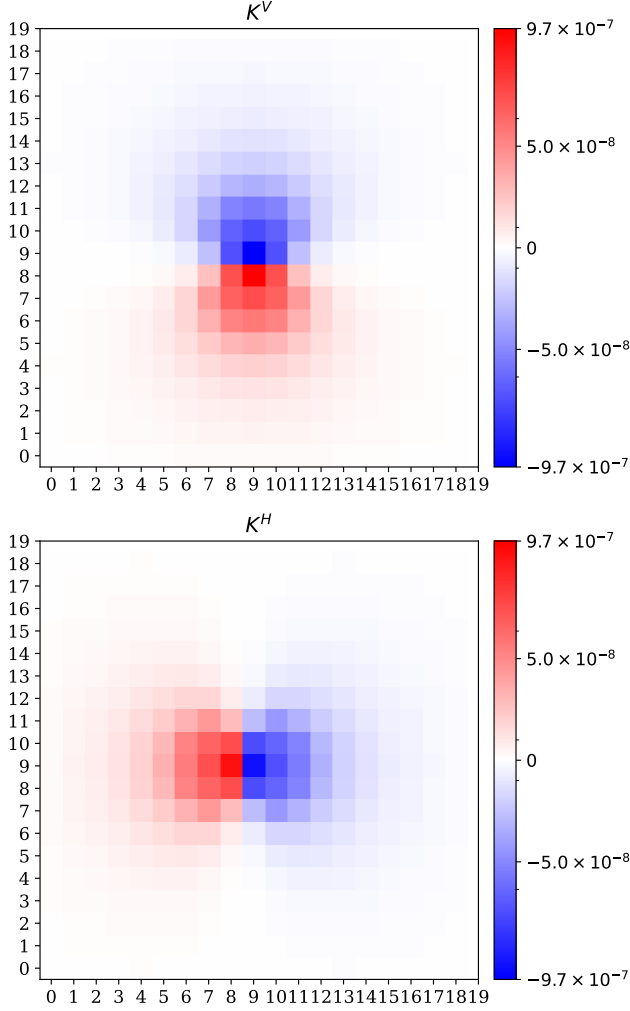


Figure 11. Example brighter-fatter correction kernels K^V (vertical) and K^H (horizontal) derived from the electrostatic BFE model for amplifier C03 on LSSTCam detector 94. The diverging color scale shows the fractional charge redistributed across pixel boundaries; each kernel sums to zero to conserve charge and exhibits the antisymmetric dipole structure that moves flux from the brighter pixel to its neighbors.

iterative convolutions. Unlike the [W. R. Coulton et al. \(2018\)](#) algorithm used for DP1 ([NSF-DOE Vera C. Rubin Observatory Team et al. 2025](#)), which requires multiple convolutions to reach convergence, we perform exactly two convolutions with the horizontal and vertical boundary-shift matrices.

4.9. Bias

We describe how master biases are constructed (overscan handling, trimming, combination statistic, masking) and the metrics used to monitor time stability.

4.10. Dark

We describe how master darks are produced (scaling by exposure time, cosmic-ray rejection, hot pixel treatment) and how residual structures are assessed.

4.11. Flats

We describe how flat-field calibrations are created (illumination correction strategy, normalization conventions, handling fringing/stray light) and how uniformity is quantified.

5. INSTRUMENT SIGNATURE REMOVAL FOR DP2 SCIENCE DATA

Figure 12 lists the ISR correction steps in the order they are applied to science images for DP2. This section integrates the calibration products described in §4 and summarizes how they compose during routine science processing. Corrections are applied in reverse chronological order relative to the photon transfer chain (§2.2 and Figure 3). Steps that undo readout-electronics effects therefore appear before steps that undo detector-level effects, and additive corrections precede multiplicative ones such as flat-fielding.

5.1. ISR Pipeline Overview

The LSSTCam has a particular photon transfer chain and therefore a particular ISR correction pipeline. The following outline follows Figure 12 step by step. Each item names the correction applied, and the reason it sits at this location in the processing chain.

1. **Convert integer to float.** Raw images arrive as integer arrays. This first step promotes pixel values to 64-bit floating point without changing their physical meaning.
2. **Dither counts.** A uniform random offset in $[-0.5, 0.5)$ ADU is added to every pixel. This breaks the correlation between true signal and integer quantization before continuous corrections are applied, reducing systematic bias when later steps interpolate, convolve, or divide the image. This step is essentially a marginalization step before a full low-signal, differential non-linearity correction can be measured and implemented.
3. **Serial overscan correction.** An electronic, clock-injected offset plus smaller row-to-row variations are derived from the serial overscan and subtracted from the imaging pixels while the data are still in native analog-to-digital units (ADU). Overscan correction must precede gain conversion because the overscan bias is measured and removed in the same units as the raw readout.

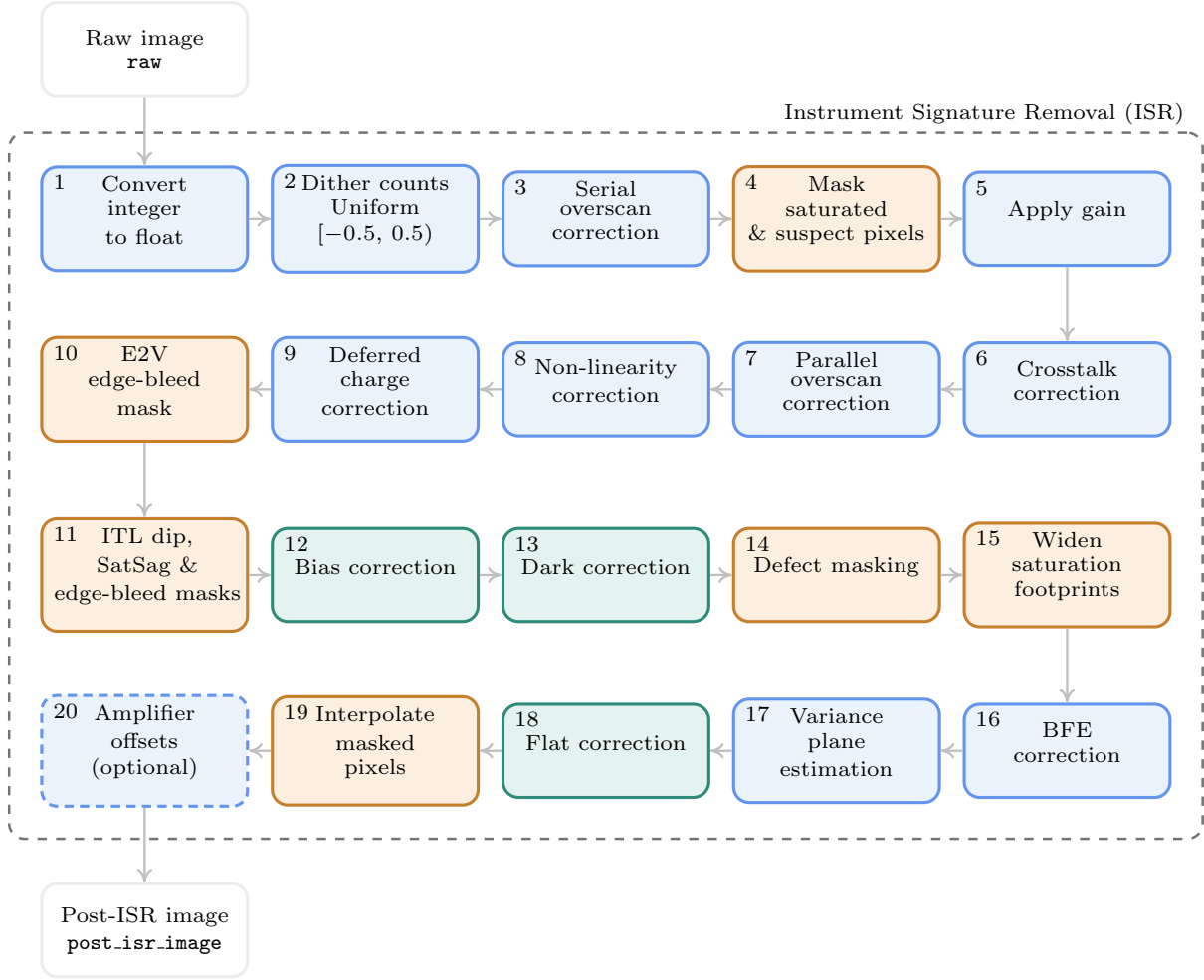


Figure 12. Outline of the Instrument Signature Removal Pipeline (ISR) applied to LSSTCam science images for DP2. The steps in the pipeline follow a very specific sequence determined by the physics of the instrument signature and where it enters in the photon transfer chain.

4. **Mask saturated and suspect pixels.** Pixels above the PTC turnoff saturation threshold (§4.7) get flagged as both saturated (“SAT”) and suspect (“SUSPECT”) in the pixel bit mask before further signal corrections. Early masking prevents corrupted or non-physical pixel values from biasing downstream estimates that assume a well-behaved signal.
5. **Apply gain.** Per-amplifier gains derived from the PTC (§4.7) convert pixel values from ADU to electrons. Electron units are the native domain for deferred-charge modeling, brighter-fatter correction, and variance plane estimation, all of which were calibrated assuming a linear conversion from measured counts to stored charge.
6. **Crosstalk correction.** Electrical coupling between adjacent amplifier outputs is removed using

the crosstalk matrix (§4.3). Crosstalk is applied after gain conversion so that coupled signals are corrected in electron units, consistent with how the matrix was measured.

7. **Parallel overscan correction.** Analogous to the serial overscan step, the parallel overscan region provides a column-direction estimate of readout offset that is subtracted from the imaging area. It follows crosstalk correction because amplifier coupling can inject signal into overscan regions, and removing crosstalk first yields a cleaner overscan bias estimate.
8. **Non-linearity correction.** The double-spline linearizer (§4.5) maps measured counts to a linearized electron count by subtracting absolute and amplifier-relative spline corrections. This step must precede deferred-charge correction because

the deferred-charge model and its calibration were fit assuming that signal-dependent readout non-linearities have already been removed (§4.6).

9. **Deferred charge correction.** Residual charge left in pixels during serial readout—from global charge transfer inefficiency, local electronic offset in the output amplifier, and serial charge traps on ITL sensors—is corrected using the parameters fit in §4.6. This step sits late in the readout-electronics portion of the chain because deferred charge is imprinted during serial transfer, after non-linearities in the output path have acted on the signal. We do not correct deferred charge on E2V sensors because the deferred charge level is already below the level defined by [Ž. Ivezić & The LSST Science Collaboration \(2018\)](#).
10. **E2V edge-bleed mask.** We flag the “SUSPECT” mask plane bit for pixels in E2V amplifiers that show uncorrectable charge spill from bright regions at the serial-register edge.
11. **ITL dip, SatSag, and edge-bleed masks.** We flag the “SUSPECT” mask plane bit for ITL sensors that exhibit a pixel column depression in response near certain amplifier boundaries (the “ITL dip”), a sag in apparent signal after saturation (“SatSag”), and edge bleeding analogous to the E2V case. These vendor-specific masks follow deferred-charge correction because the artifacts they mark are readout- and saturation-related structures that should be evaluated on linearized, CTI-corrected data.
12. **Bias correction.** A combined bias frame (§4.9) is subtracted to remove the fixed-pattern electronic offset that remains after overscan subtraction. Overscan correction handles the spatially static electronic structure imprinted in the images before charge readout.
13. **Dark correction.** The combined dark frame (§4.10), scaled by the science exposure time, is subtracted to remove thermal dark current accumulated during exposure integration. Dark correction follows bias subtraction because both are additive offsets, and the dark frame is constructed from bias-subtracted dark exposures.
14. **Defect masking.** Persistent bad pixels, columns, and other static defects identified during calibration (§4.4) are merged into the pixel mask. Applying the defect mask after deferred-charge,

bias, and dark correction places it once readout-electronics effects and integration-period offsets have been removed, matching the processing state in which the defect catalog was built and ensuring that later defect footprint widening and interpolation operate on the full static bad-pixel map.

15. **Widen saturation footprints.** The saturation mask is expanded spatially to include pixels affected by charge spill and trails from saturated sources. This step follows defect masking so that all static bad regions are known before the saturation footprint is grown into neighboring pixels.
16. **Brighter-fatter correction.** The electrostatic brighter-fatter effect (§4.8) redistributes flux among neighboring pixels to undo charge-cloud repulsion in the silicon. In the photon transfer model (Figure 3), brighter-fatter is the earliest detector-level effect on incident photons, so its correction appears correspondingly late in ISR. It is applied after the image has been converted to linearized electron units and after additive calibration-frame corrections. The correction also needs to match the boundary-shifts, which were also calibrated from PTC covariances measured after these corrections.
17. **Variance plane estimation.** An expected variance is assigned to each pixel using the PTC-derived gain and read noise (§4.7). The variance plane is computed after gain application and brighter-fatter correction so that it reflects the electron units and pixel correlations relevant to source detection and weighting in downstream analyses.

At this stage the expected per-pixel variance follows the Poisson-plus-read-noise model

$$\sigma_{ij}^2 = \frac{F_{ij}}{g_a} + \left(\frac{\sigma_n(a)}{g_a} \right)^2, \quad (14)$$

where F_{ij} is the science image value in the current ISR units, g_a is the PTC gain for amplifier a (electrons per ADU), and $\sigma_n(a)$ is the read noise in electrons. For DP2 science processing the image is already in electron units, so $g_a = 1$ and Eq. 14 reduces to $\sigma_{ij}^2 = F_{ij} + \sigma_n(a)^2$. Pixels with non-positive variance are flagged in the mask.

Since the variance plane is used to estimate the uncertainty on just the charge accumulated in the image, it needs to be computed before flat-field correcting.

18. **Flat correction.** The normalized flat field (§4.11) is divided into the image to correct pixel-to-pixel variations in quantum efficiency and optical throughput. Flat-fielding is intentionally late in the pipeline: it is a multiplicative correction that must be applied only after all additive electronic and dark offsets have been removed, so that the flat field encodes relative sensitivity rather than residual bias structure.
19. **Interpolate masked pixels.** Pixels in the “SAT”, “BAD”, and “UNMASKEDNAN” mask planes are filled by interpolation from neighboring unmasked values; “SUSPECT” pixels are flagged but not interpolated by default. Interpolation is performed after flat-fielding so that both the science signal and the replacement values are in the same calibrated flux units expected by algorithms that assume a continuous image (for example, background estimation and certain astrometric measurements).
20. **Amplifier offsets (optional).** Small per-amplifier multiplicative adjustments derived from flat-field residuals may be applied as a final optional step to reduce residual flux discontinuities at amplifier boundaries. This step is optional because the PTC gain solution already includes average amplifier matching (§4.7); the offset correction addresses any remaining channel-to-channel offsets visible after the full ISR chain.

Together, these steps transform the raw integer readout into a floating-point, full-calibrated image in electron units with an associated variance plane and pixel mask used in downstream data release processing tasks. It is crucial for the ordering to match the physics of the detectors and the reverse chronological ordering of the photon transfer chain. Running the processing pipeline with misplaced steps would either apply a correction in the wrong physical units or leave residual structure that invalidates a downstream calibrations

5.2. Curated Calibrations and Header Provenance

Science exposures processed for DP2 are matched to a curated calibration collection (§4.1) appropriate to their calibration epoch (§3.3). The collection bundles the certified bias, dark, flat, defect mask, crosstalk matrix, linearizer, deferred-charge parameters, PTC table, and brighter-fatter distortion model, together with any auxiliary data products required for masking or optional corrections (§4.2). When the observing conditions, sequencer configuration, or calibration campaign change

enough to warrant a new epoch, a new curated collection is produced and certified before it is attached to incoming science data.

Exposure header metadata records the calibration epoch, the identifier of the curated collection used, and a per-step record of which ISR corrections were applied or skipped. This provenance makes it possible to reproduce the processing of any released image, compare products generated across software or calibration versions, and audit whether optional steps such as amplifier-offset correction were enabled for a given dataset. The verification, acceptance, and distribution context for these metadata fields is described in §7.1.

6. DISCUSSION

Describe how calibrations have changed across different calibration epochs (sequencer changes).

List the set of criteria that prompt a new round of calibrations.

7. VERIFICATION, ACCEPTANCE, AND CERTIFICATION

This section defines the quality metrics for calibration products and ISR outputs. Here we define the criteria used to promote products to “accepted” and “certified”.

7.1. Data products, Distribution, and User Access

Describe the output schema, distribution process (exporting/importing, rucio, TAXICAB tracking), and user access.

We enumerate the primary data products (calibration frames, ISR outputs, masks, and metadata tables), describe naming/versioning conventions, and summarize the provenance tracked for each product (inputs, software versions, and configuration).

Briefly describe how users discover and retrieve products (e.g., via a data butler/repository interface) and recommended query patterns.

Be sure to mention that header metadata contains information about whether a particular ISR step was applied/not applied and which calibration dataset was used.

7.2. Verification

We list (possibly in a table) the automated verification tests for each data product (sanity checks, analysis plots, detailed plots, distributional checks, and science test images) and the thresholds that determine acceptance/rejection of different calibration data products.

7.3. Acceptance

This section will describe the calibration acceptance process (TAXICAB).

Describe how verified products are compared against earlier baselines to reveal regressions or deviations, and how acceptance decisions are documented.

7.4. Certification

Describe the final certification step in the context of the data “butler” and file system storage.

7.5. Data Monitoring

Discuss how we monitor incoming streams of new data for quality (e.g. rubinTV, plot navigator, trend monitoring with chronograph).

8. LIMITATIONS & KNOWN ISSUES

Summarize known limitations for DP2 (instrumental systematics not fully corrected, edge cases, missing calibrations, validity constraints) and near-term roadmap items.

9. CONCLUSION

This paper documents the calibration-production algorithms, instrument signature removal (ISR) workflow, and quality-assurance framework used to generate DP2 calibration products for LSSTCam. DP2 is the first end-to-end demonstration of data processing with on-sky LSSTCam dataset, and it establishes a reproducible reference for the first stage of processing in Data Release Processing (DRP) pipeline.

We organize calibration production and ISR around the electronic detector model introduced in §2.2, where each instrument artifact get its own associated calibration dataset and correction algorithm. Calibrations are built on top of other calibrations (summarized in Figure 5), requiring intermediate applications of ISR (summarized in Figure 12). In general, the pipelines are derived and applied in the reverse chronological order of the photon transfer chain. For DP2, we describe production algorithms and ISR for crosstalk, defect masking, non-linearity, deferred charge (CTI), the photon transfer curve (PTC), the brighter-fatter effect, and the classical bias, dark, and flat-field calibrations (§4), and we integrate their application in the science ISR pipeline (Figure 12, §5).

Where detailed validation is already in place, DP2 calibrations meet or approach the requirements needed for commissioning-era science. These products are accompanied by a verification, acceptance, and certification workflow (§7) intended to make calibration quality auditable, and we record the relevant provenance in exposure dataset metadata for the science community (§5.2).

DP2 nevertheless reflects commissioning-era conditions: calibration data were collected before dome completion and full thermal stabilization (§1), detector operating modes and sequencer configurations evolved across epochs (§6), and calibrations and correction tools for some artifacts remain under active development (§8). Users should treat residual focal-plane non-uniformities, epoch-dependent systematics, and incomplete coverage effects as known limitations when interpreting DP2 data products and deciding paths/configurations for science analyses.

Looking toward Data Release 1 (DR1), we expect iterative improvements in three areas: *algorithms* (refined CTI and trap modeling, expanded color-dependent brighter-fatter treatment), *operations* (more stable dome and calibration-system performance, clearer calibration-epoch boundaries, and expanded automation through verification and acceptance pipelines), and *diagnostics* (trending analyses, regression and alerts for calibration changes against baselines, and quality metrics on science-images for downstream pipeline acceptance criteria). The DP2 workflow documented here is the baseline from which those improvements will be measured; maintaining versioned, reproducible calibration production will remain essential as LSSTCam transitions from data previews during commissioning to data releases over the full 10-year survey.

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Facility: Rubin

Software: LSST Science Pipelines

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